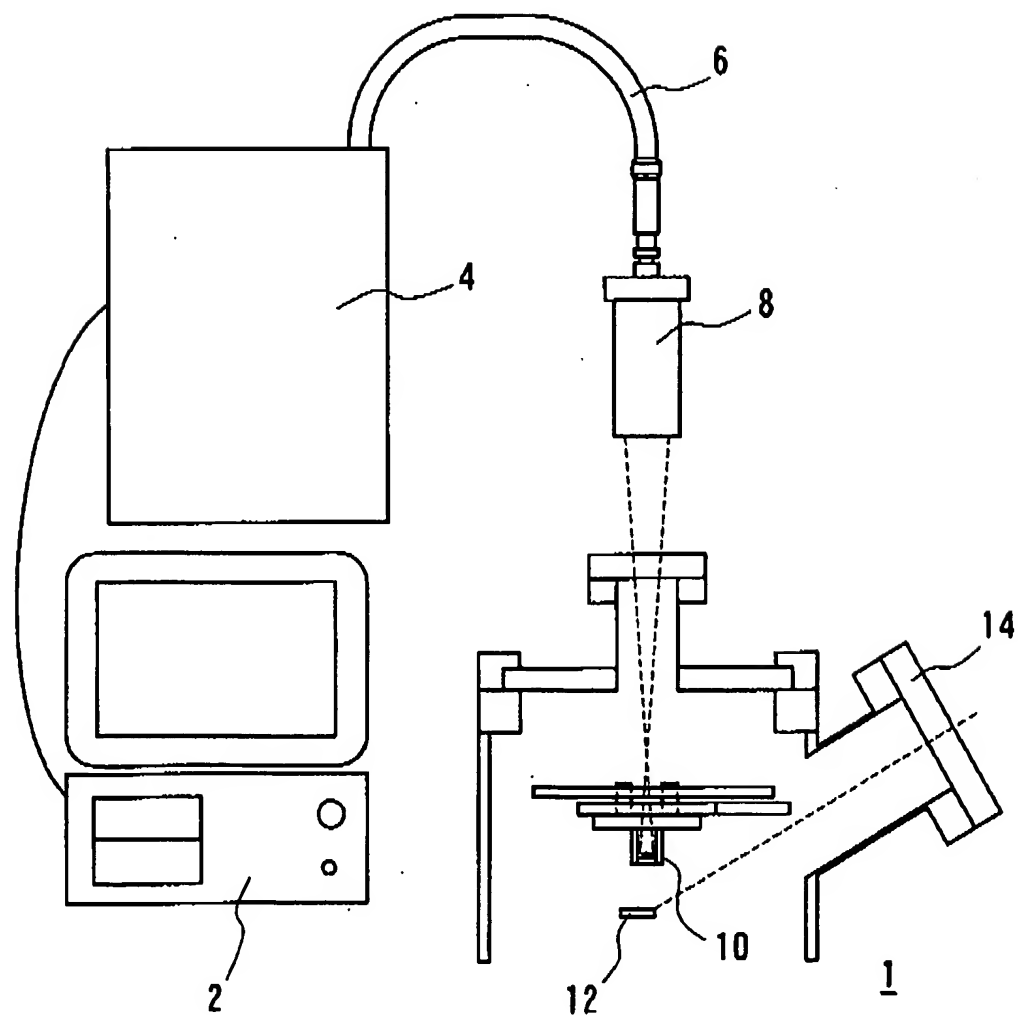


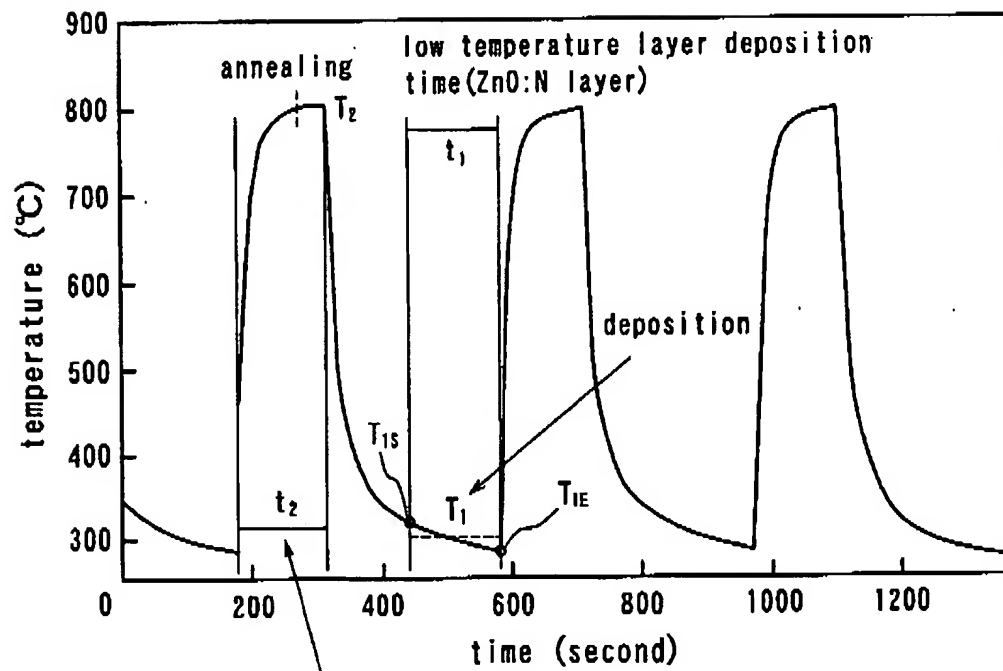
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FIG. 1

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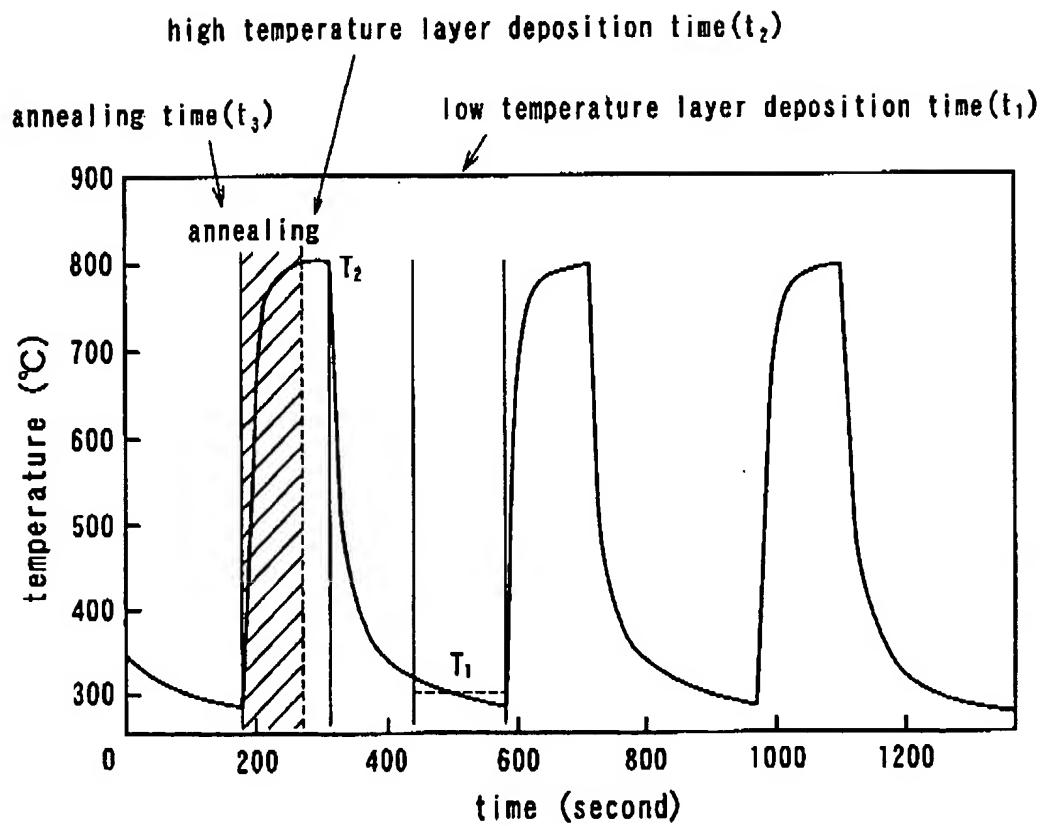
FIG. 2



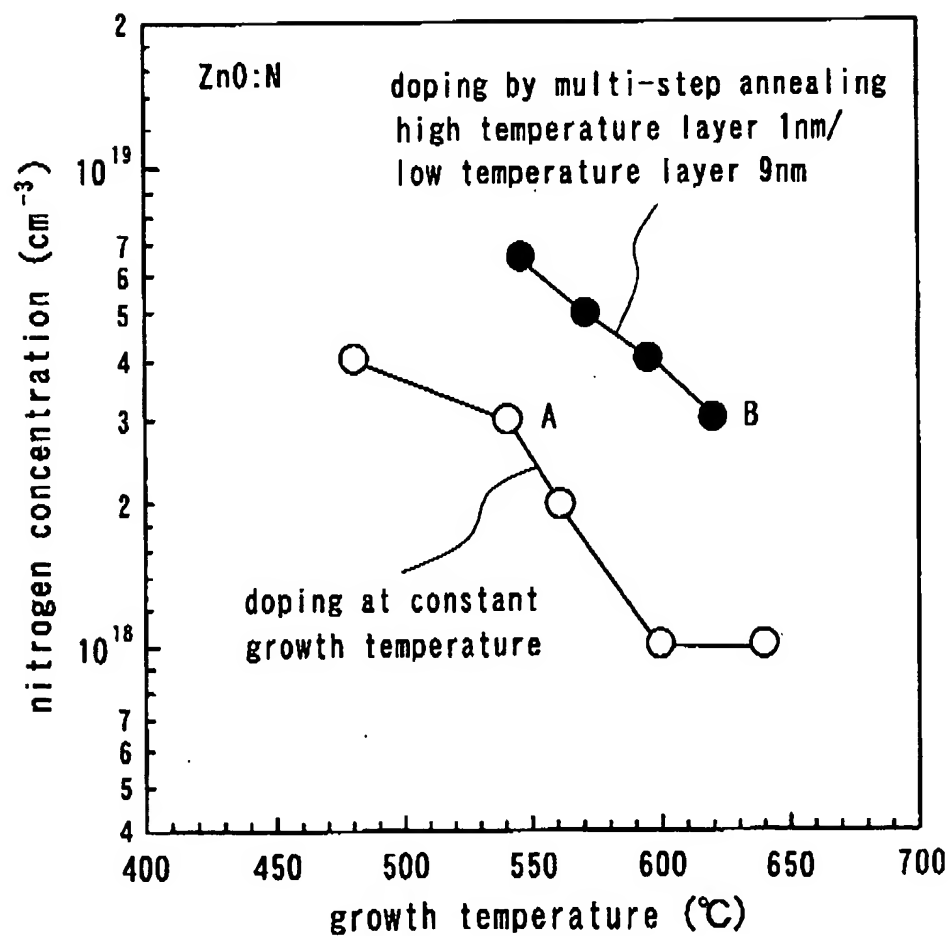
high temperature annealing time

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FIG. 3



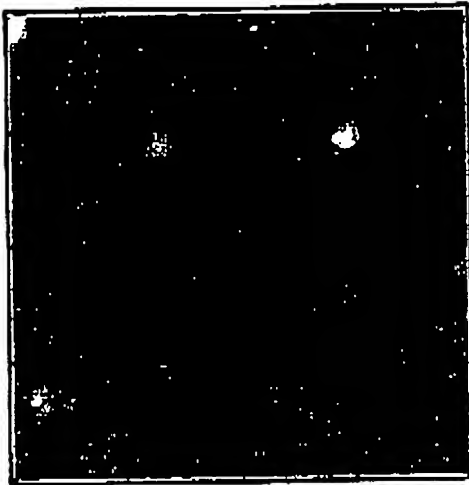
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FIG. 4

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FIG. 5

A



resistivity $\sim 5\Omega\text{cm}$

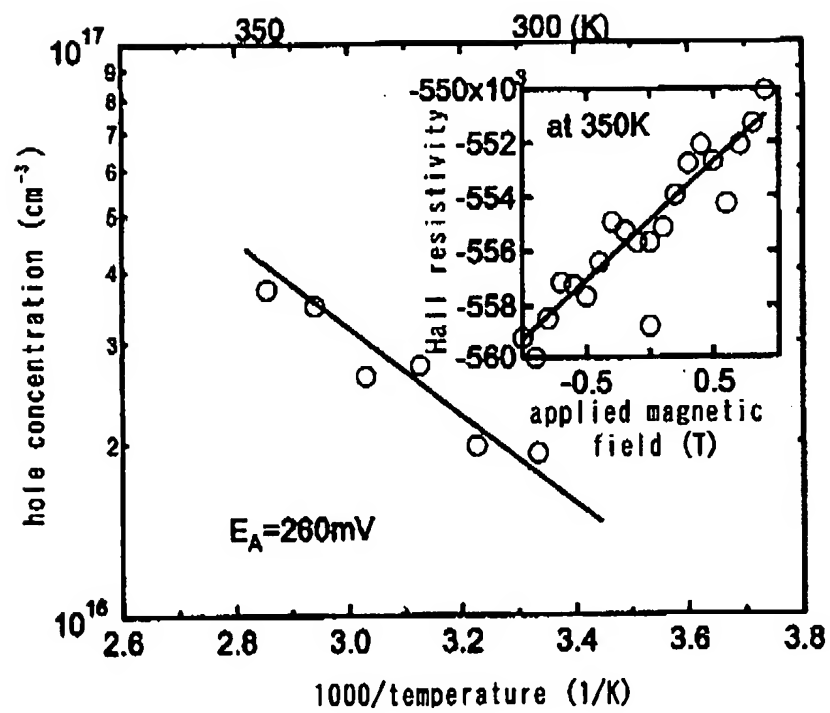
B



resistivity $\sim 100\Omega\text{cm}$

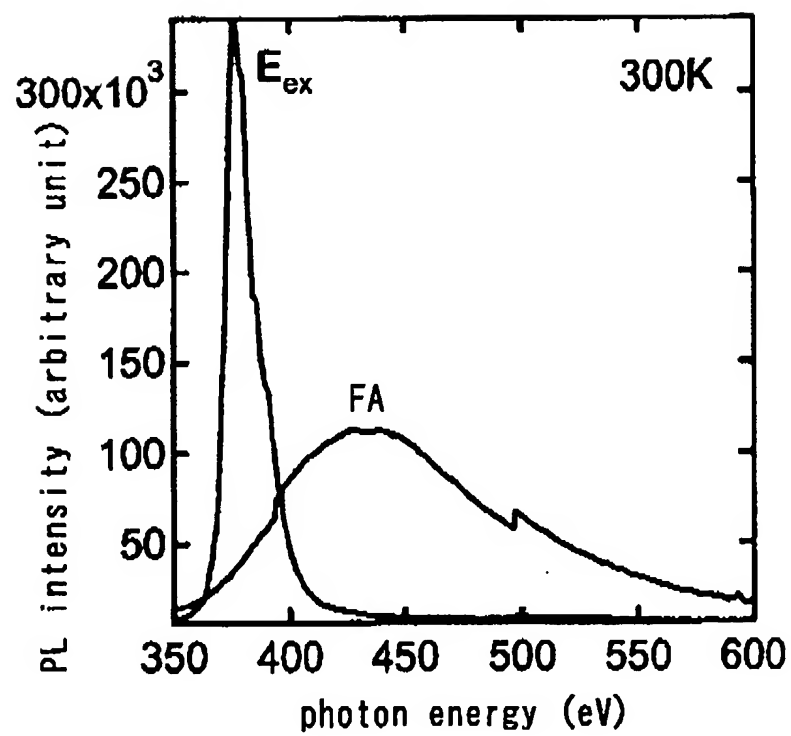
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FIG. 6

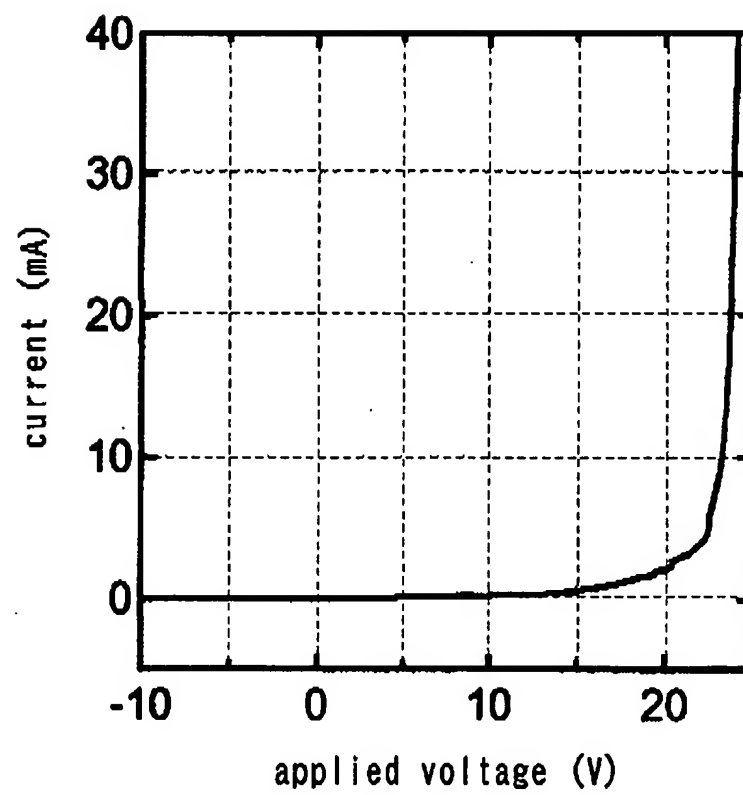


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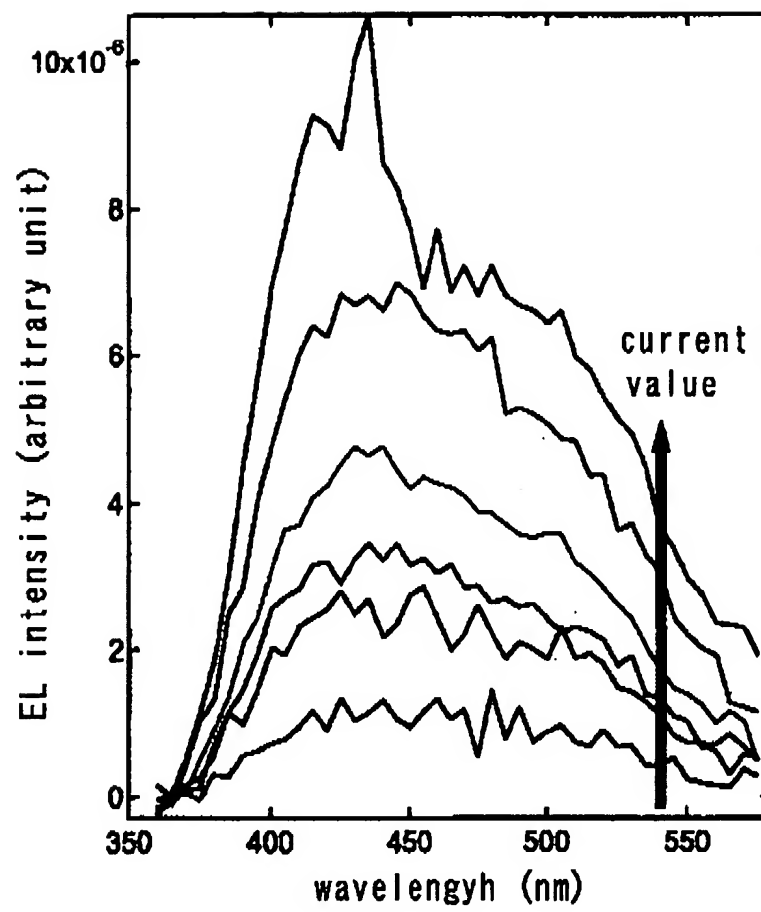
FIG. 7



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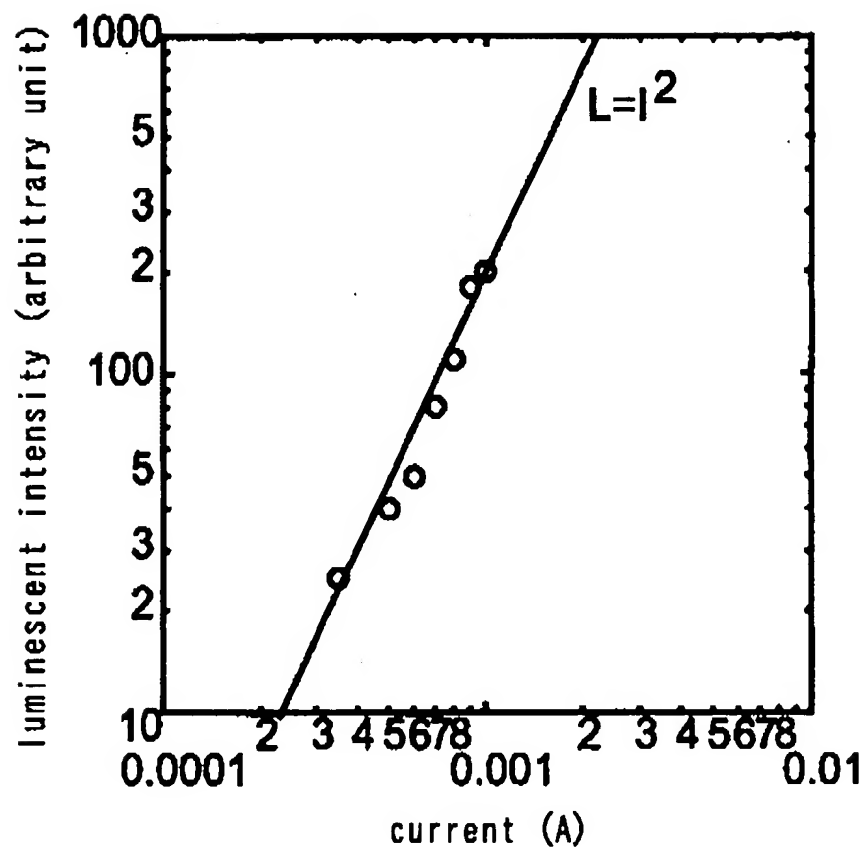
FIG. 8

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FIG. 9

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FIG. 10



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